

Supporting Information

Molecular engineering of anthracene-based emitters for highly efficient nondoped deep-blue fluorescent OLEDs

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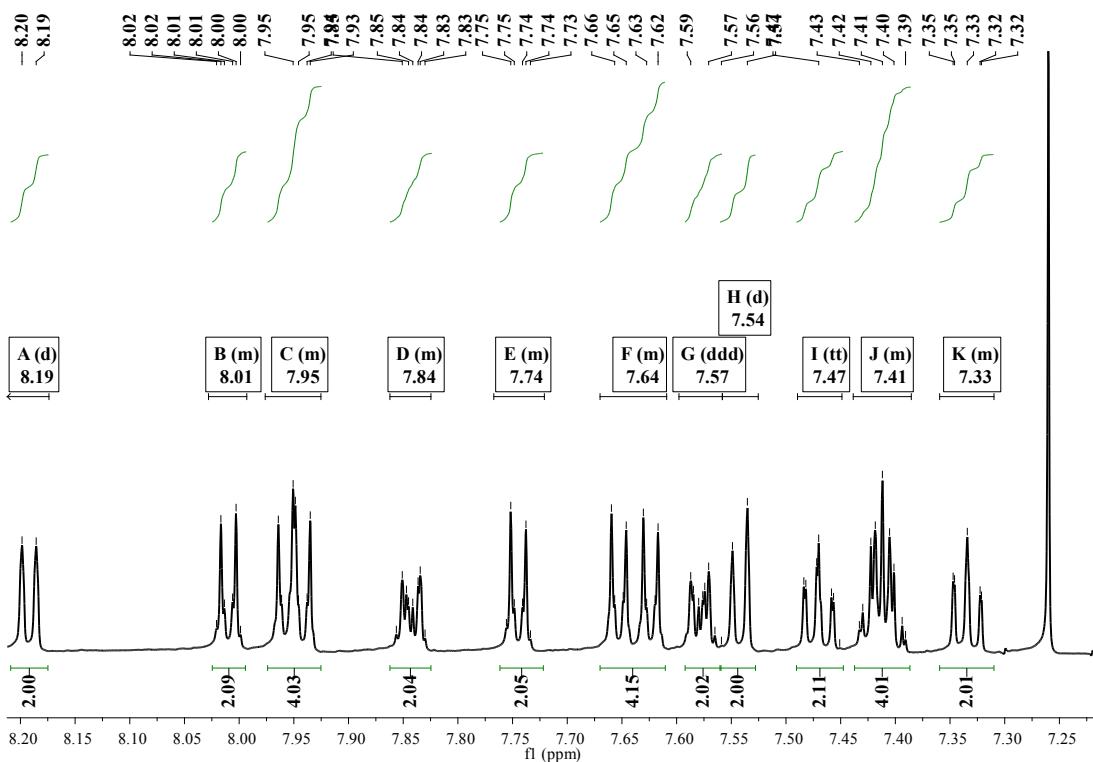


Fig. S1. The ¹H NMR spectra of *p*CzphAnBzt

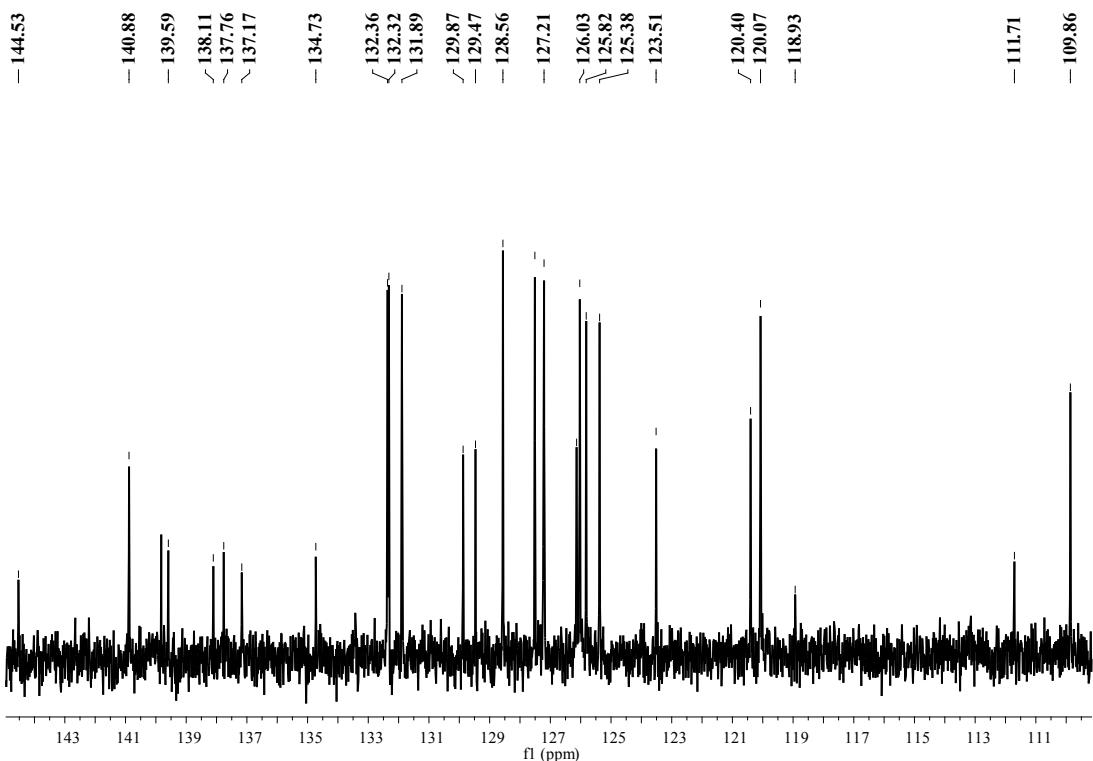


Fig. S2. The ¹³C NMR spectra of *p*CzphAnBzt.

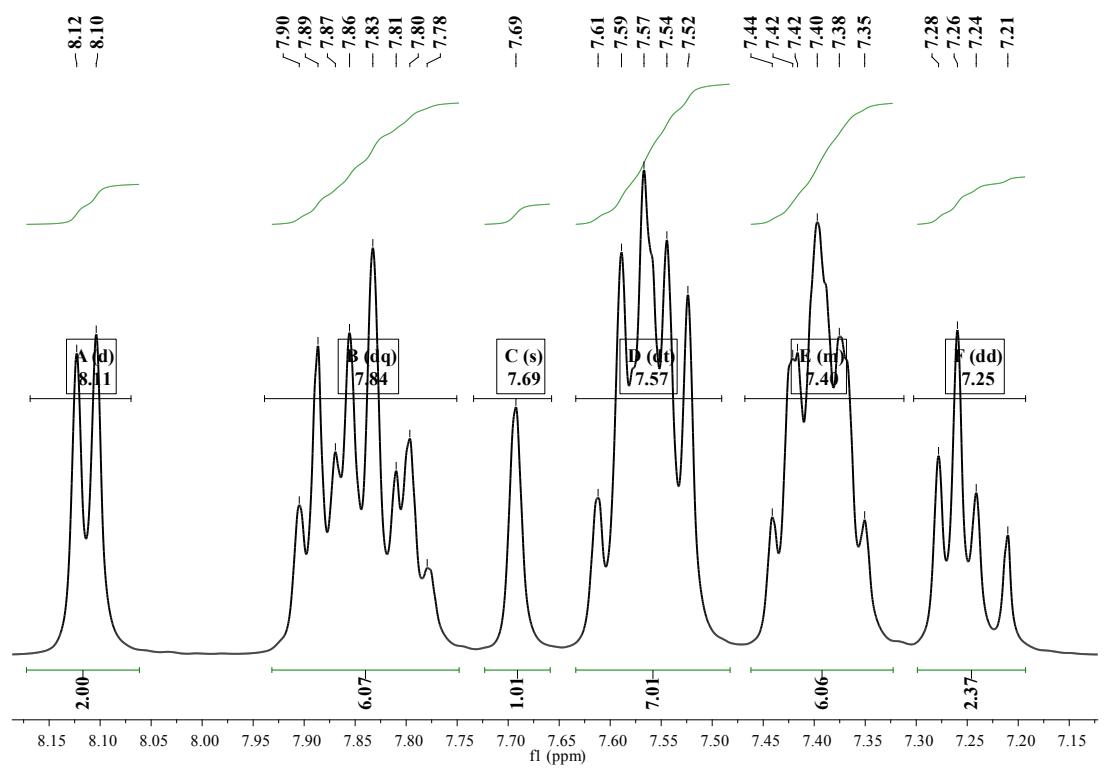


Fig. S3. The ¹H NMR spectra of *m*CzAnBzt.

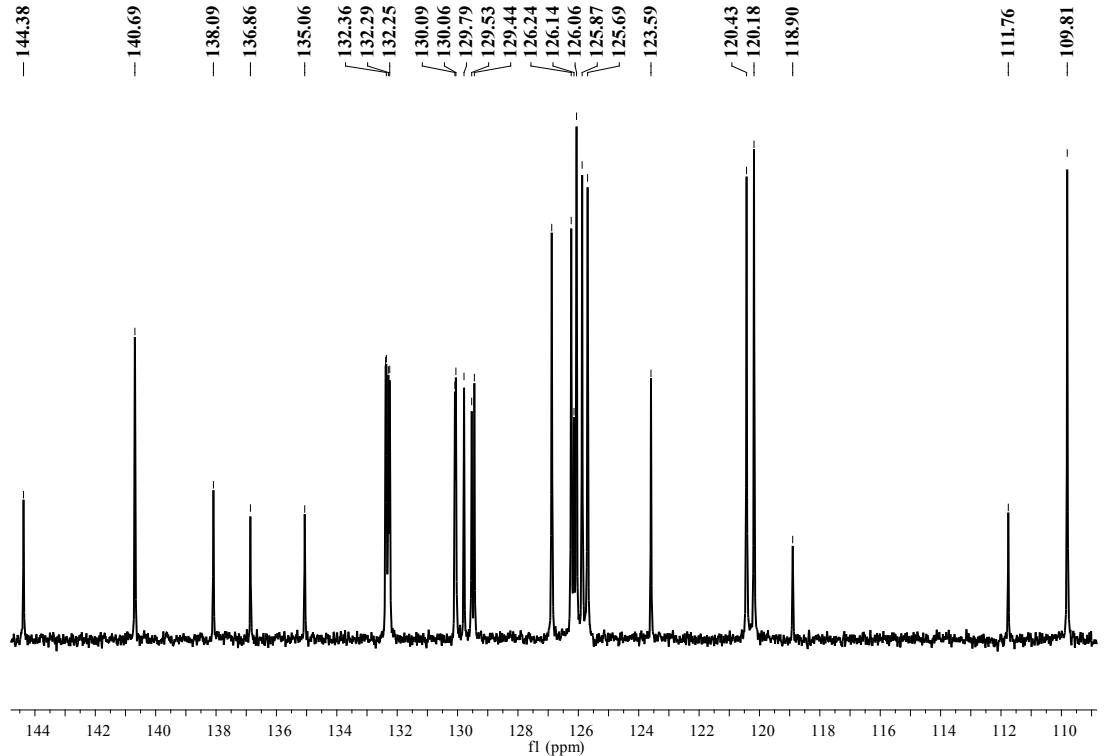


Fig. S4. The ¹³C NMR spectra of *m*CzAnBzt.

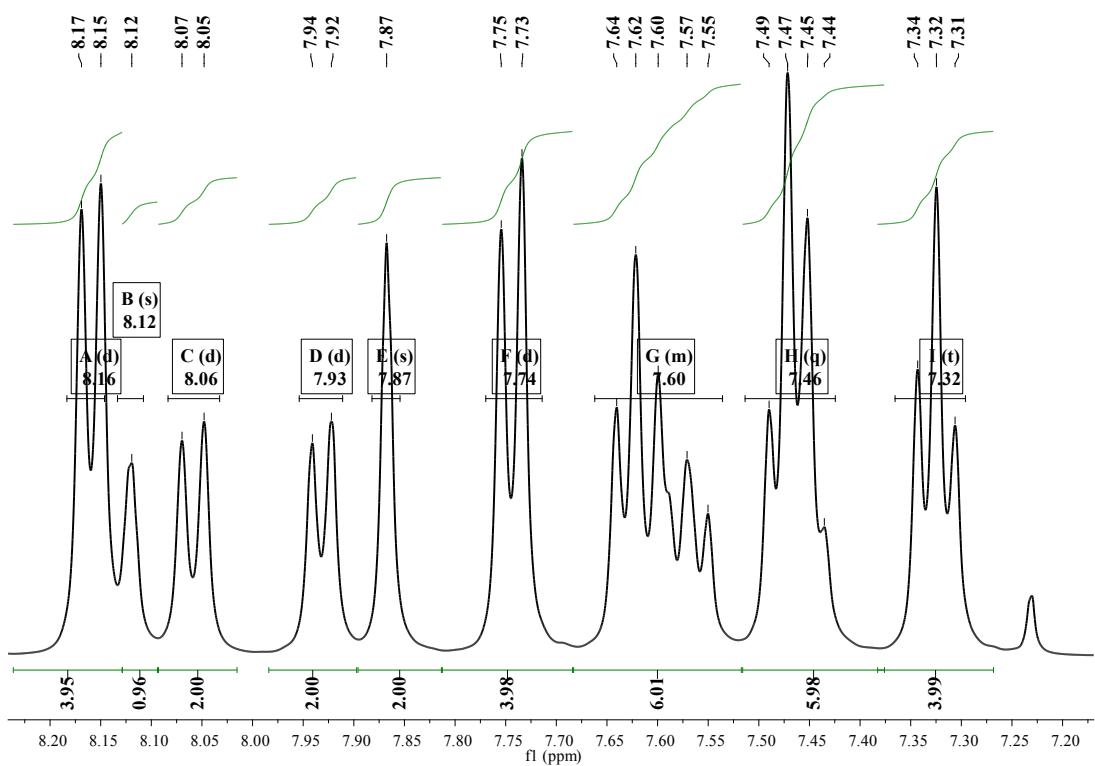


Fig. S5. The ¹H NMR spectra of *m*2CzAnBzt.

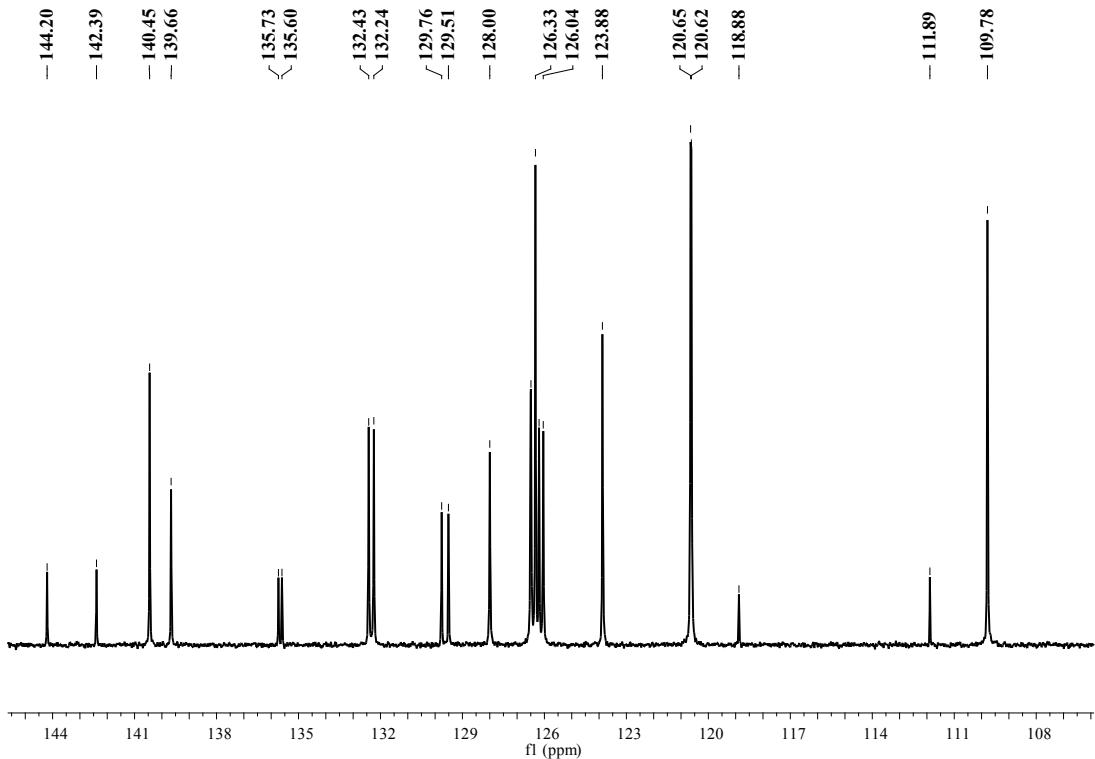


Fig. S6. The ¹³C NMR spectra of *m*2CzAnBzt.

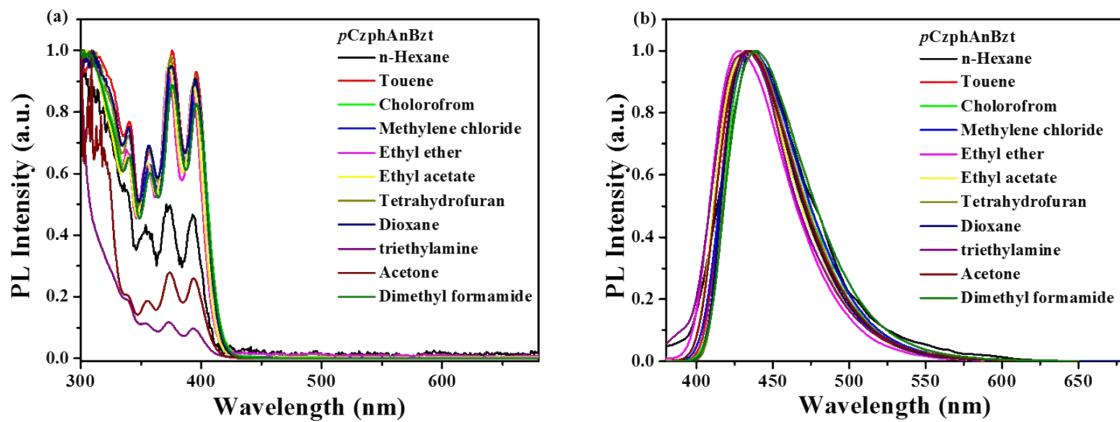


Fig. S7. The normalized UV-vis spectra (a) and normalized PL spectra (b) of *p*CzphAnBzt in different solvents.

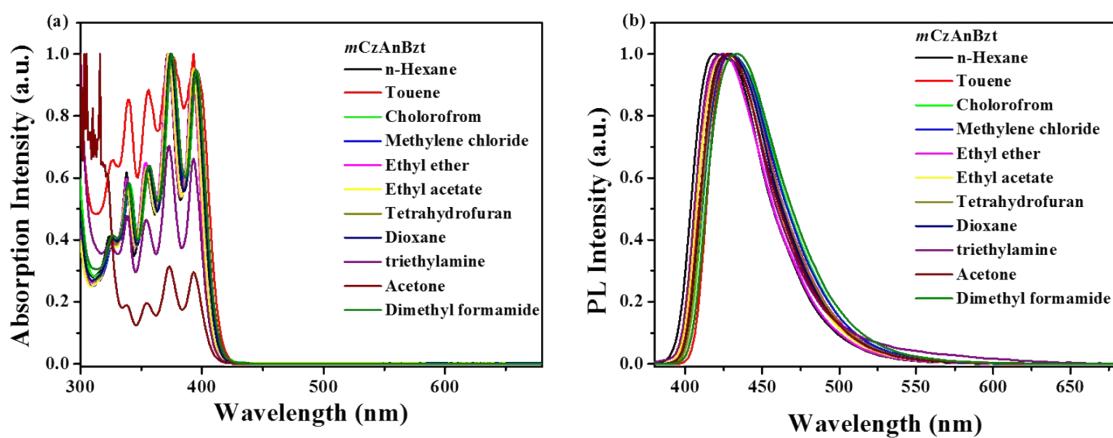


Fig. S8. The normalized UV-vis spectra (a) and normalized PL spectra (b) of *m*CzAnBzt in different solvents.

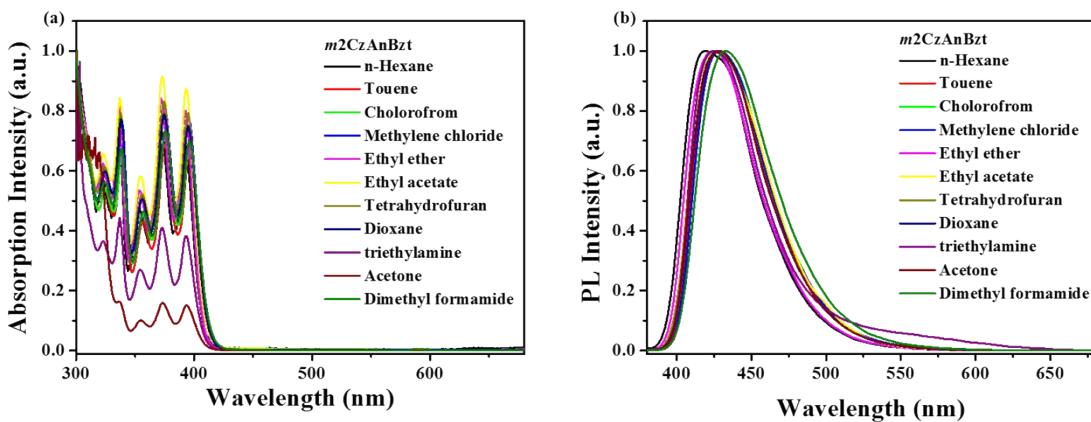


Fig. S9. The normalized UV-vis spectra (a) and normalized PL spectra (b) of *m*2CzAnBzt in different solvents.

Table S1. Detailed information of absorption and emission peak positions of *p*CzphAnBzt, *m*CzAnBzt and *m*2CzAnBzt in different solvents.

Solvent	<i>p</i> CzphAnBzt		<i>m</i> CzAnBzt		<i>m</i> 2CzAnBzt	
	λ_a (nm)	λ_f (nm)	λ_a (nm)	λ_f (nm)	λ_a (nm)	λ_f (nm)
Hexane	393	436	392	418	392	420
Touene	396	433	393	430	396	428
Choloroform	396	436	396	430	396	428
Methylene chloride	396	437	395	430	395	428
Ethyl ether	393	428	392	424	393	424
Ethyl acetate	393	432	393	426	393	428
Tetrahydrofuran	395	436	394	428	395	428
Dioxane	395	432	395	428	395	428
Triethylamine	393	434	393	424	393	424
Acetone	394	435	393	428	394	428
Dimethyl formamide	396	439	395	434	396	432

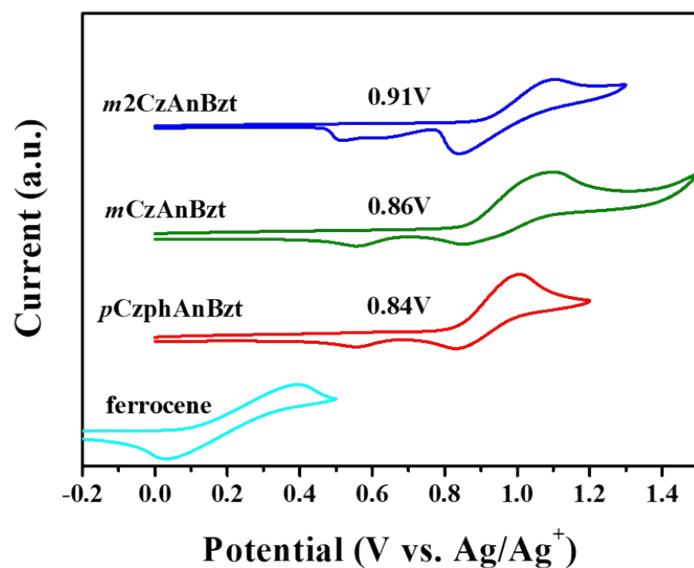


Fig. S10. Cyclic voltammetry scans of *p*CzPhAnBzt, *m*CzAnBzt and *m*2CzAnBzt.

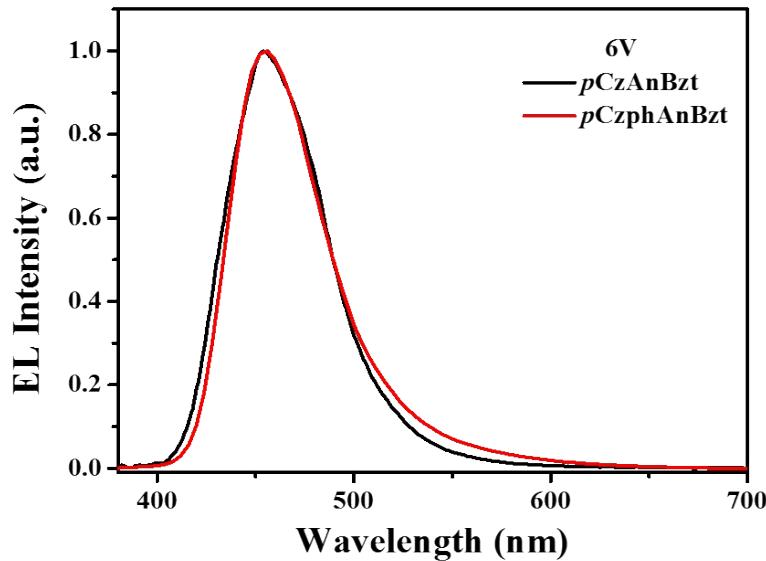


Fig. S11. Normalized EL spectra of *p*CzAnBzt and *p*CzphAnBzt at 6 V.

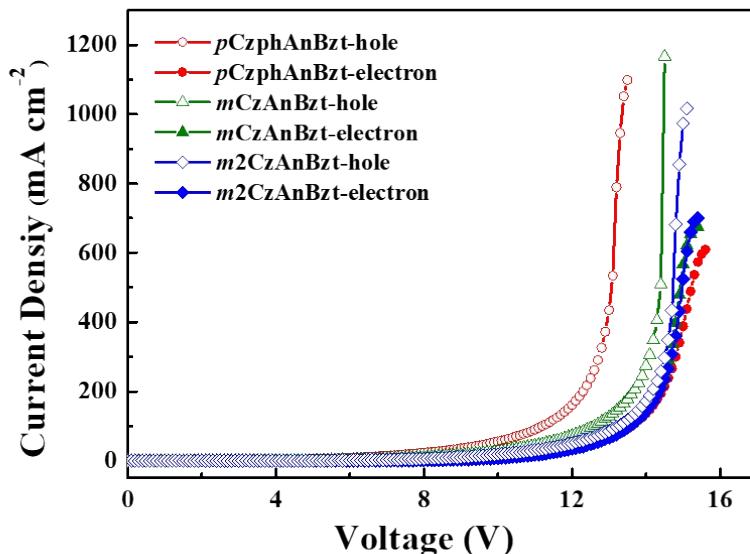


Fig. S12. The hole-only and electron-only devices of *p*CzPhAnBzt-, *m*CzAnBzt- and *m*2CzAnBzt-based nondoped device. The devices structure of hole-only: ITO/HATCN (15 nm)/TAPC (50 nm)/TCTA (5 nm)/EML (20 nm)/TCTA (5 nm)/TAPC (50 nm)/HATCN (15 nm)/Al(150 nm), and the devices structure of electron-only: ITO/LiF(1 nm)/TmPyPB (40 nm)/EML (20)/TmPyPB (40 nm)/LiF(1 nm)/Al(150 nm).

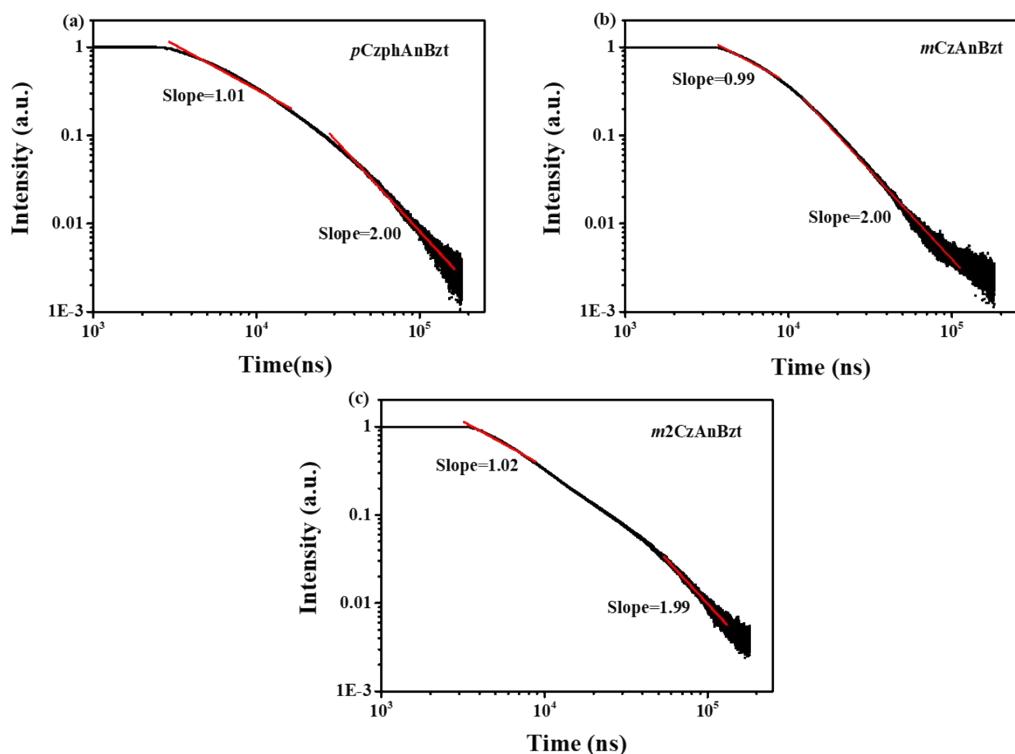


Fig. S13. Amplified EL decay of the delayed component of ***p*CzPhAnBzt**-, ***m*CzAnBzt**- and ***m*2CzAnBzt**-based nondoped device at 5V.

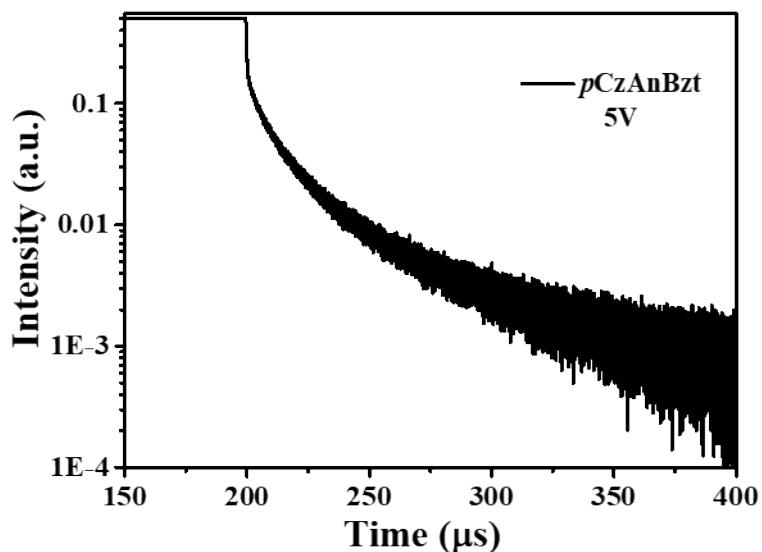


Fig. S14. Transient EL decays of ***p*CzAnBzt**-based nondoped devices at 5 V.

Table S2. Optical parameters of ***p*CzAnBzt-**, ***p*CzphAnBzt-**, ***m*CzAnBzt-** and ***m*2CzAnBzt**-based nondoped devices calculated by transient EL decays at 5V voltage.

compound	$I_{\text{delay}}/I_{\text{steady}}$	$\eta_{\text{TTA}}^{\text{a}}$	$\eta_{\text{rad}}^{\text{b}}$	EQE _{ca} ^c (%)	EQE _{ex} ^d (%)
<i>p</i>CzAnBzt	0.4096	0.1734	0.4234	7.53	9.23
<i>p</i>CzphAnBzt	0.2980	0.1061	0.3561	3.63	6.75
<i>m</i>CzAnBzt	0.1977	0.0616	0.3116	5.89	7.95
<i>m</i>2CzAnBzt	0.3228	0.1192	0.3692	5.87	7.36

^a Exciton utilization by TTA process. ^b Total ratio of radiative excitons. ^c EQE calculated using equation EQE= $(\gamma \times \eta_{\text{rad}} \times \Phi_{\text{PL}}) \eta_{\text{out}}$, assuming r=1, $\eta_{\text{out}}=0.3$. ^d Experiment value.